

Features

- Neutral Point Clamped Three-Level Inverter Module
- Low Inductive Layout
- Solderable Pins

Benefits

- Higher System Efficiency
- Reduced Cooling Requirements
- Low Conduction Losses Over Temperature

Applications

- Solar Inverters
- Uninterruptable Power Supplies Systems

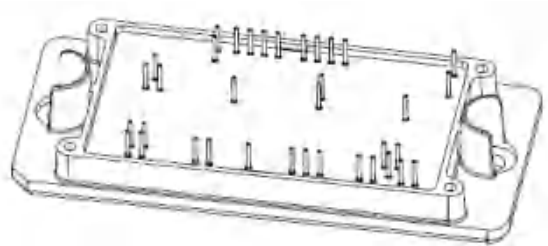


Table 1 Absolute Maximum Ratings (Ta = 25 °C)

Parameter	Symbol	Value	Unit
OUTER IGBT (Q1, Q4)			
Collector-emitter voltage	V _{CES}	650	V
Gate-emitter voltage	V _{GE}	±20	V
Continuous collector current @ T _C = 80°C, T _J = 175°C	I _C	270	A
Pulsed collector current @ T _J = 175°C	I _{CP}	810	A
Junction temperature	T _J	-40 to +175	°C
INNER IGBT (Q2, Q3)			
Collector-emitter voltage	V _{CES}	650	V
Gate-emitter voltage	V _{GE}	±20	V
Continuous collector current @ T _C = 80°C, T _J = 175°C	I _C	270	A
Pulsed collector current @ T _J = 175°C	I _{CP}	810	A
Junction temperature	T _J	-40 to +175	°C
DIODE(D1,D2,D3,D4)			
Peak repetitive reverse voltage	V _{RRM}	650	V
Continuous forward current @ T _C = 80°C, T _J = 175°C	I _F	188	A
Repetitive peak forward current @ T _J = 175°C	I _{FRM}	563	A
I ² t-value@ V _R = 0 V, T _p = 10 ms, T _{vj} = 150°C	I ² t	1800	A ² s
Junction temperature	T _J	-40 to +175	°C
DIODE(D5,D6)			
Peak repetitive reverse voltage	V _{RRM}	650	V
Continuous forward current @ T _C = 80°C, T _J = 175°C	I _F	230	A
Repetitive peak forward current @ T _J = 175°C	I _{FRM}	690	A
I ² t-value@ V _R = 0 V, T _p = 10 ms, T _{vj} = 150°C	I ² t	9800	A ² s
Junction temperature	T _J	-40 to +175	°C
INSULATION PROPERTIES			
Isolation test voltage, t = 1 s, 50 Hz	V _{ISO}	4000	V _{RMS}
RECOMMENDED TEMPERATURE			
Storage temperature	T _{stg}	-40 to +125	°C
Operating temperature	T _{op}	-40 to +150	°C

Table 2 Characteristics Values

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit	
IGBT (Q1,Q4)							
Collector–emitter saturation voltage	V _{CE(sat)}	V _{GE} = 15 V, I _C = 450 A	T _j = 25°C	-	1.6	2.2	V
		V _{GE} = 15 V, I _C = 450 A	T _j = 150°C	-	1.85	-	
Gate–emitter threshold voltage	V _{GE(TH)}	V _{GE} = V _{CE} , I _C = 4 mA	T _j = 25°C	3.2	3.8	4.4	V
Total gate charge	Q _g	V _{GE} = ±15 V, V _{CE} = 480 V	T _j = 25°C	-	1.6	-	μC
Gate-source leakage current	I _{GES}	V _{GE} = 20 V, V _{CE} = 0 V	T _j = 25°C	-	-	100	nA
Collector–emitter voltage	V _{(BR)CES}	V _{GE} = 0 V	T _j = 25°C	650	-	-	V
Collector–emitter cutoff current	I _{CES}	V _{CE} = 650 V, V _{GE} = 0 V	T _j = 25°C	-	-	100	μA
Input capacitance	C _{iss}	V _{GE} = 0 V, V _{CE} = 20 V, f = 10 KHz	T _j = 25°C	-	24	-	nF
Output capacitance	C _{oss}		T _j = 25°C	-	1.9	-	
Reverse transfer capacitance	C _{rss}		T _j = 25°C	-	0.14	-	
Turn-on delay time (inductive load)	t _{d on}	V _{GE} = -7 V / +15 V, V _{CE} = 400 V, I _C = 150 A, R _{Gon} = 9.4 Ω, R _{Goff} = 15.7 Ω	T _j = 25°C	-	75	-	ns
Rise time (inductive load)	t _r		T _j = 150°C	-	58	-	
			T _j = 25°C	-	33	-	
Turn-off delay time (inductive load)	t _{d off}		T _j = 150°C	-	38	-	
			T _j = 25°C	-	757	-	
Fall time (inductive load)	t _f		T _j = 150°C	-	804	-	
			T _j = 25°C	-	44	-	
Turn - on switching loss	E _{on}		T _j = 25°C	-	4.7	-	
		T _j = 150°C	-	6.8	-		
Turn - off switching loss	E _{off}	T _j = 25°C	-	2.6	-		
		T _j = 150°C	-	3.3	-		
IGBT (Q2,Q3)							
Collector–emitter saturation voltage	V _{CE(sat)}	V _{GE} = 15 V, I _C = 450 A	T _j = 25°C	-	1.6	2.2	V
		V _{GE} = 15 V, I _C = 450 A	T _j = 150°C	-	1.85	-	

Parameter	Symbol	Conditions		Min.	Typ.	Max.	Unit
Gate-emitter threshold voltage	$V_{GE(TH)}$	$V_{GE} = V_{CE}$, $I_C = 4 \text{ mA}$	$T_j = 25^\circ\text{C}$	3.2	3.8	4.4	V
Total gate charge	Q_g	$V_{GE} = \pm 15 \text{ V}$, $V_{CE} = 480 \text{ V}$	$T_j = 25^\circ\text{C}$	-	1.6	-	μC
Gate-source leakage current	I_{GES}	$V_{GE} = 20 \text{ V}$, $V_{CE} = 0 \text{ V}$	$T_j = 25^\circ\text{C}$	-	-	100	nA
Collector-emitter voltage	$V_{(BR)CES}$	$V_{GE} = 0 \text{ V}$	$T_j = 25^\circ\text{C}$	650	-	-	V
Collector-emitter cutoff current	I_{CES}	$V_{CE} = 650 \text{ V}$, $V_{GE} = 0 \text{ V}$	$T_j = 25^\circ\text{C}$	-	-	100	μA
Input capacitance	C_{iss}	$V_{GE} = 0 \text{ V}$, $V_{CE} = 20 \text{ V}$, $f = 10 \text{ KHz}$	$T_j = 25^\circ\text{C}$	-	24	-	nF
Output capacitance	C_{oss}		$T_j = 25^\circ\text{C}$	-	1.9	-	
Reverse transfer capacitance	C_{rss}		$T_j = 25^\circ\text{C}$	-	0.14	-	
Turn-on delay time (inductive load)	t_{don}	$V_{GE} = -7 \text{ V} / +15 \text{ V}$, $V_{CE} = 400 \text{ V}$, $I_C = 150 \text{ A}$, $R_{Gon} = 4.3 \Omega$, $R_{Goff} = 32 \Omega$	$T_j = 25^\circ\text{C}$	-	35	-	ns
			$T_j = 150^\circ\text{C}$	-	26	-	
Rise time (inductive load)	t_r		$T_j = 25^\circ\text{C}$	-	25	-	
			$T_j = 150^\circ\text{C}$	-	30	-	
Turn-off delay time (inductive load)	t_{doff}		$T_j = 25^\circ\text{C}$	-	1100	-	
			$T_j = 150^\circ\text{C}$	-	1300	-	
Fall time (inductive load)	t_f		$T_j = 25^\circ\text{C}$	-	27	-	
			$T_j = 150^\circ\text{C}$	-	33	-	
Turn - on switching loss	E_{on}	$V_{GE} = -7 \text{ V} / +15 \text{ V}$, $V_{CE} = 400 \text{ V}$, $I_C = 150 \text{ A}$, $R_{Gon} = 4.3 \Omega$, $R_{Goff} = 32 \Omega$	$T_j = 25^\circ\text{C}$	-	1.62	-	mJ
			$T_j = 150^\circ\text{C}$	-	2.56	-	
Turn - off switching loss	E_{off}		$T_j = 25^\circ\text{C}$	-	5.62	-	
			$T_j = 150^\circ\text{C}$	-	6.63	-	

NEUTRAL POINT DIODE (D5, D6)

Diode forward voltage	V _F	I _F = 450 A	T _j = 25°C	-	1.65	2.05	V
		I _F = 450 A	T _j = 150°C	-	1.75	-	
Reverse recovery time	T _{RR}	V _{GE} = -7 V / +15 V, V _{CE} = 400 V, I _C = 150 A, R _{Gon} = 9.4 Ω, R _{Goff} = 15.7 Ω	T _j = 25°C	-	173	-	ns
			T _j = 150°C	-	215	-	
Reverse recovery charge	Q _{RR}		T _j = 25°C	-	8.68	-	μC
			T _j = 150°C	-	20.4	-	
Peak reverse recovery current	I _{RRM}		T _j = 25°C	-	120	-	A
			T _j = 150°C	-	184	-	
Reverse recovery energy	E _{RR}		T _j = 25°C	-	2.02	-	mJ
			T _j = 150°C	-	4.02	-	

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit	
INVERSE DIODE (D1,D2,D3,D4)							
Diode forward voltage	V _F	I _F = 100 A	T _j = 25°C	-	1.23	1.65	V
		I _F = 100 A	T _j = 150°C	-	1.18	-	
		I _F = 200 A	T _j = 25°C		1.58	-	
		I _F = 200 A	T _j = 150°C		1.64		
Reverse recovery time	T _{RR}	V _{GE} = -7 V / +15 V, V _{CE} = 400 V, I _C = 150 A, R _{Gon} = 4.3 Ω, R _{Goff} = 32 Ω	T _j = 25°C	-	342	-	ns
	T _j = 150°C		-	432	-		
Reverse recovery charge	Q _{RR}		T _j = 25°C	-	2.58	-	μC
			T _j = 150°C	-	3.99	-	
Peak reverse recovery current	I _{RRM}		T _j = 25°C	-	43.3	-	A
			T _j = 150°C	-	48.1	-	
Reverse recovery energy	E _{RR}	T _j = 25°C	-	2.52	-	mJ	
		T _j = 150°C	-	4.02	-		

Table 3 Thermal Resistance

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Thermal resistance – chip-to-heatsink (D1,D2,D3,D4)	R_{thJH}	Thermal grease , $\lambda = 2.8 \text{ W/mK}$	-	0.41	-	$^{\circ}\text{C/W}$
Thermal resistance – chip-to-case (D1,D2,D3,D4)	R_{thJC}		-	0.32	-	$^{\circ}\text{C/W}$
Thermal resistance – chip-to-heatsink (Q2,Q3)	R_{thJH}	Thermal grease , $\lambda = 2.8 \text{ W/mK}$	-	0.28	-	$^{\circ}\text{C/W}$
Thermal resistance – chip-to-case (Q2,Q3)	R_{thJC}		-	0.18	-	$^{\circ}\text{C/W}$
Thermal resistance – chip-to-heatsink (D5, D6)	R_{thJH}	Thermal grease , $\lambda = 2.8 \text{ W/mK}$	-	0.29	-	$^{\circ}\text{C/W}$
Thermal resistance – chip-to-case (D5, D6)	R_{thJC}		-	0.19	-	$^{\circ}\text{C/W}$
Thermal resistance – chip-to-heatsink(Q1, Q4)	R_{thJH}	Thermal grease , $\lambda = 2.8 \text{ W/mK}$	-	0.24	-	$^{\circ}\text{C/W}$
Thermal resistance – chip-to-case (Q1, Q4)	R_{thJC}		-	0.16	-	$^{\circ}\text{C/W}$

Table 4 NTC-Thermistor

Parameter	Symbol	Min	Typ.	Max	Unit	Conditions
Rated resistance	R_{25}	-	22	-	$\text{k}\Omega$	$T_C = 25^{\circ}\text{C}$
Deviation of R_{100}	$\Delta R/R$	-5	-	5	%	$T_C = 100^{\circ}\text{C}$, $R_{100} = 1486 \Omega$
Power dissipation	P_{25}	-	-	20	mW	$T_{NTC} = 25^{\circ}\text{C}$
B-value	$B_{25/50}$	-	3950	-	K	B (25/50), tolerance $\pm 3\%$
B-value	$B_{25/100}$	-	3998	-	K	B (25/100), tolerance $\pm 3\%$

Table 5 Module

Parameter	Symbol	Min	Typ.	Max	Unit	Conditions
Stray Inductance	L _{CE}	-	17	-	nH	
Mounting Torque Screw:M5	M	3.0	-	5.0	N.m	
Creepage distance	d _{Creep}		12.7		mm	terminal to heatsink
Clearance	d _{Clear}		12.7		mm	terminal to heatsink
CTI			≥600			
RTI			130		°C	
Flatness of base plate				0.3	mm	
Weight			176.5		g	

Typical Characteristics

IGBT Q1, Q2, Q3, Q4 and DIODE D1, D2, D3, D4

Fig.1 Typical output characteristics IGBT
 $T_{vj} = 25^{\circ}\text{C}$

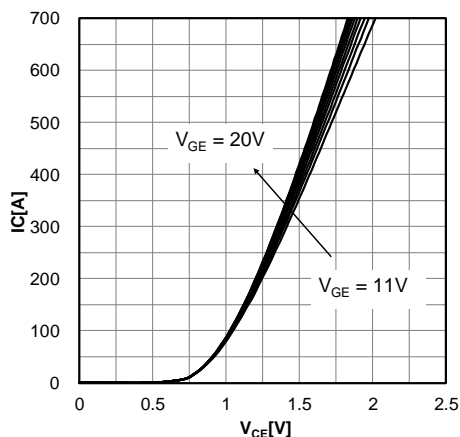


Fig.2 Typical output characteristics IGBT
 $T_{vj} = 150^{\circ}\text{C}$

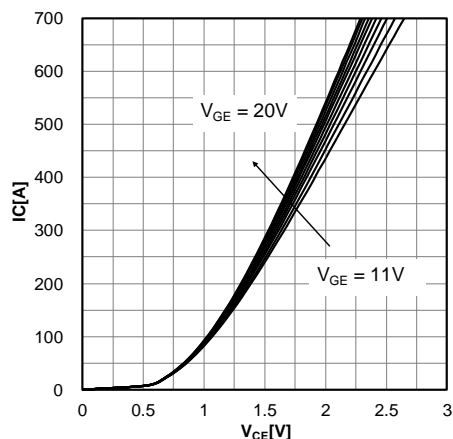


Fig.3 Body diode characteristics

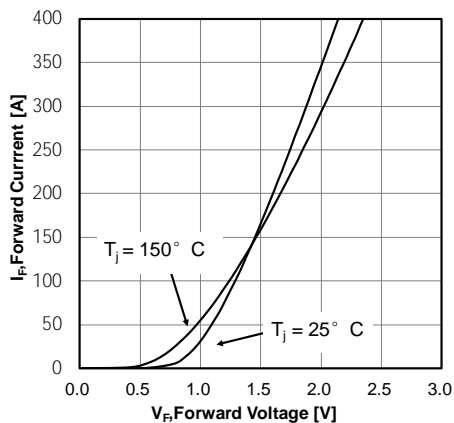


Fig.4 Transient thermal impedance (Q1, Q4)

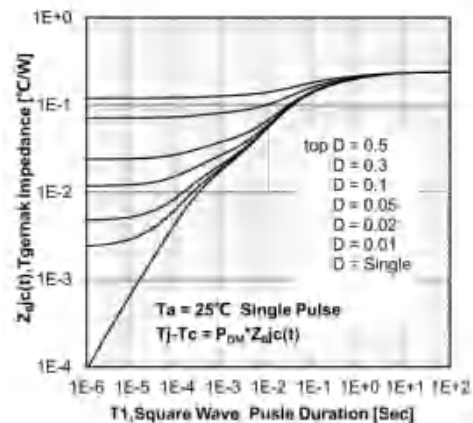


Fig.4 Transient thermal impedance (Q2, Q3)

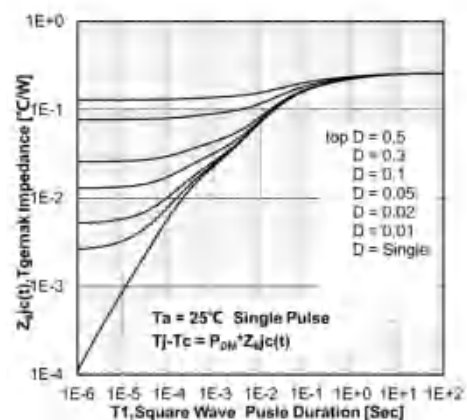
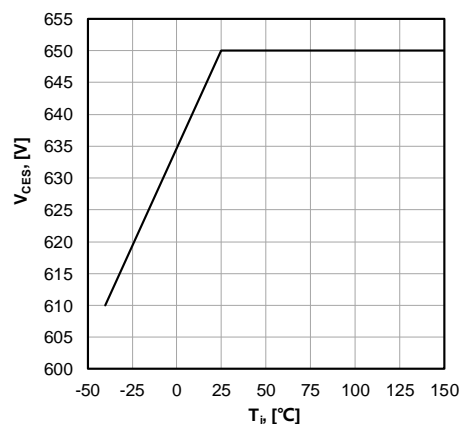
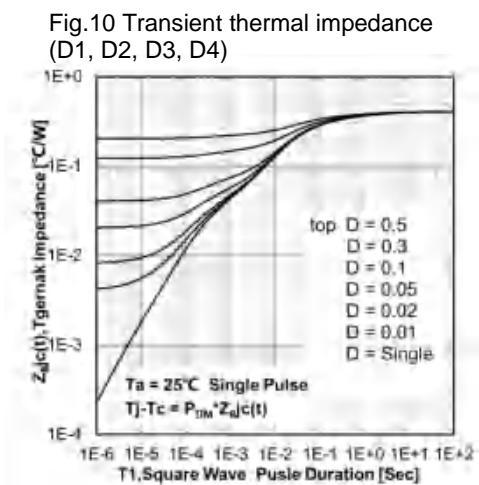
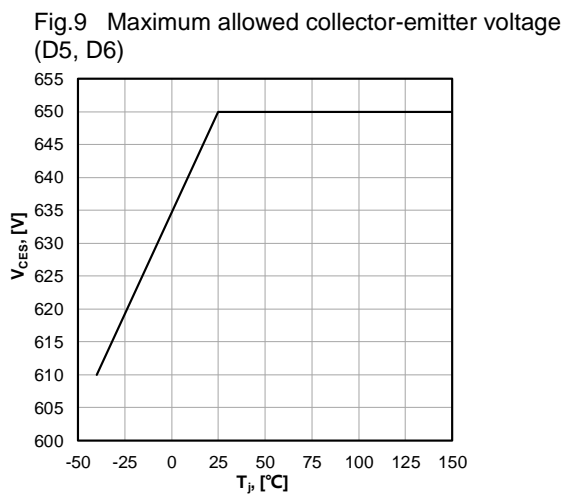
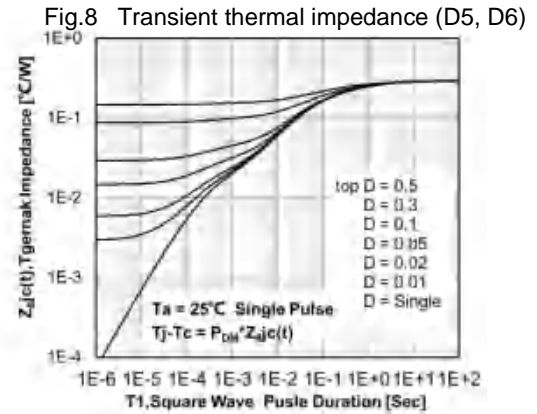
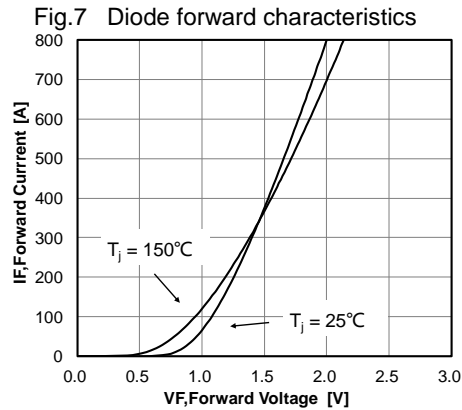


Fig.6 Maximum allowed collector-emitter voltage
(Q1, Q2, Q3, Q4)



Typical Characteristics

DIODE D5, D6



Typical Characteristics

IGBT Q1, Q4 and DIODE D5, D6

Fig.11 Switching losses IGBT, Inverter (typical)

$E_{on} = f(I_c)$, $E_{off} = f(I_c)$,
 $V_{GE} = +15\text{ V} / -7\text{ V}$, $R_{Gon} = 9.4\ \Omega$, $R_{Goff} = 16.7\ \Omega$,
 $V_{CE} = 400\text{ V}$

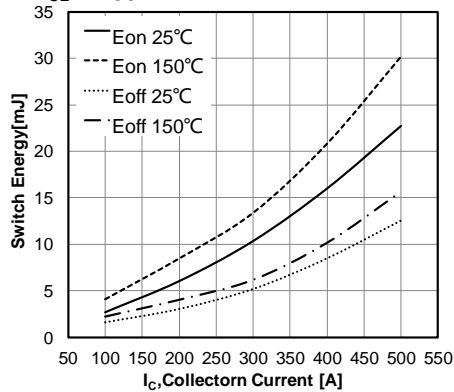
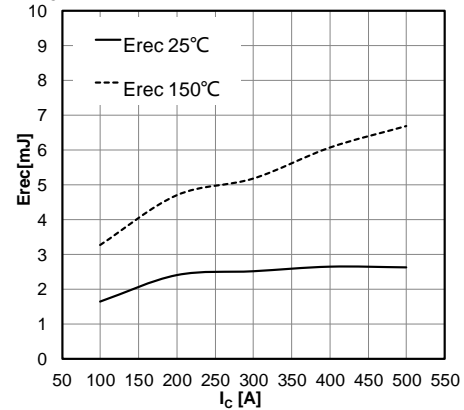


Fig.12 Switching losses IGBT, Inverter (typical)

$E_{rec} = f(I_c)$,
 $V_{GE} = +15\text{ V} / -7\text{ V}$, $R_{Gon} = 9.4\ \Omega$, $R_{Goff} = 16.7\ \Omega$,
 $V_{CE} = 400\text{ V}$



IGBT Q2, Q3 and DIODE D1, D4

Fig.13 Switching losses IGBT, Inverter (typical)

$E_{on} = f(I_c)$, $E_{off} = f(I_c)$,
 $V_{GE} = +15\text{ V} / -7\text{ V}$, $R_{Gon} = 4.3\ \Omega$, $R_{Goff} = 32\ \Omega$,
 $V_{CE} = 400\text{ V}$

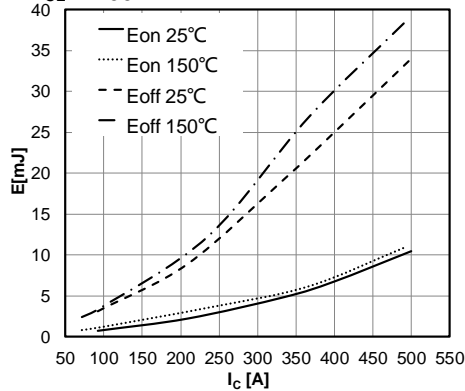


Fig.14 Switching losses IGBT, Inverter (typical)

$E_{rec} = f(I_c)$,
 $V_{GE} = +15\text{ V} / -7\text{ V}$, $R_{Gon} = 4.3\ \Omega$, $R_{Goff} = 32\ \Omega$,
 $V_{CE} = 400\text{ V}$

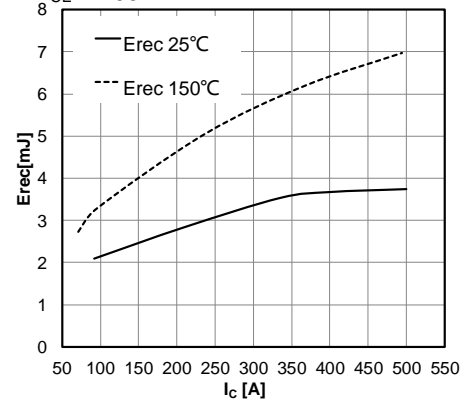


Fig.15 NTC-Thermistor-temperature characteristic (typical)

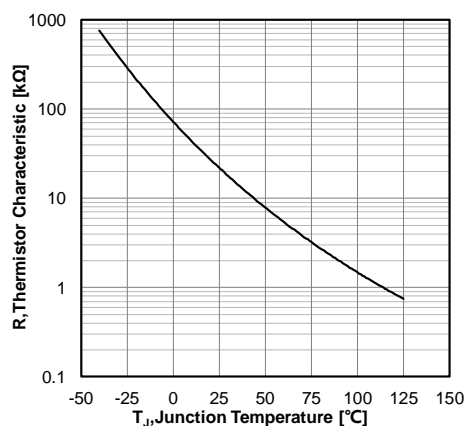
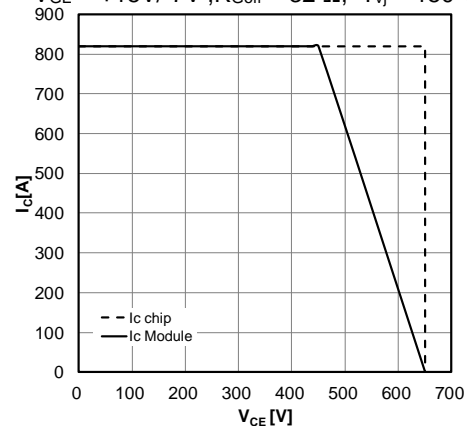
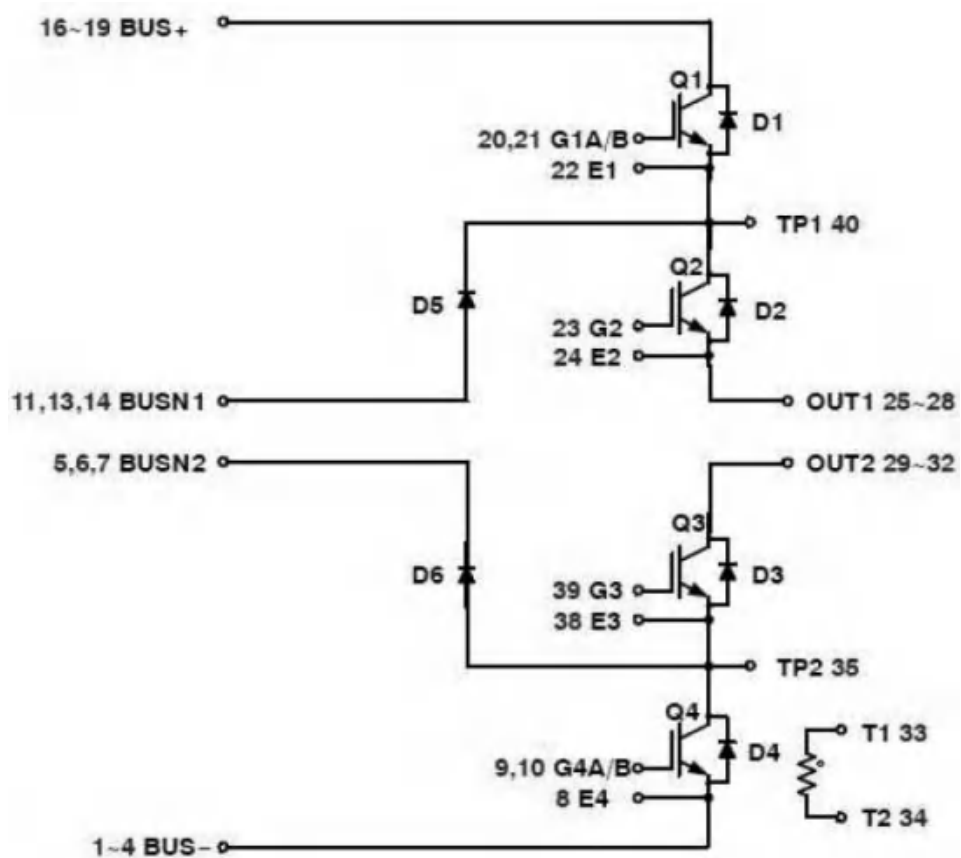


Fig.16 Reverse bias safe operating area IGBT, Inverter (RBSOA)

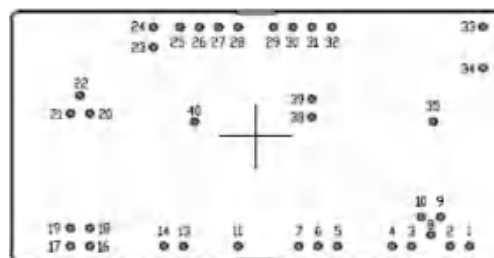
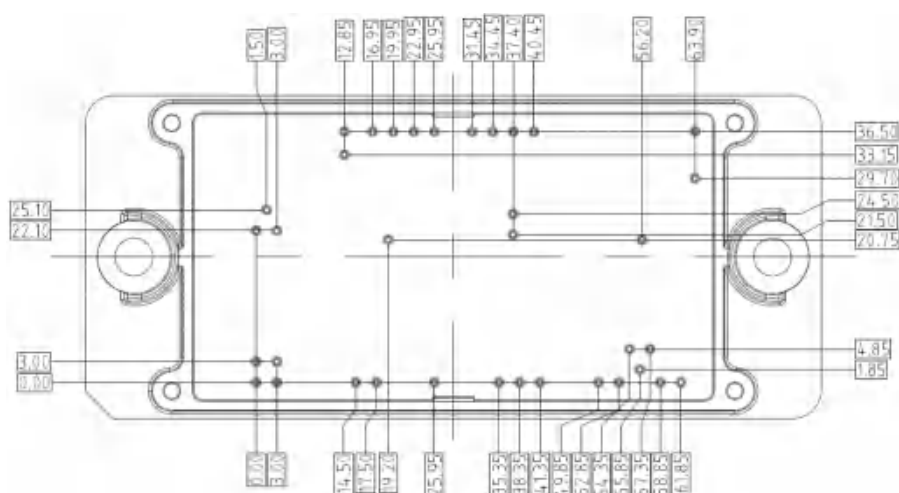
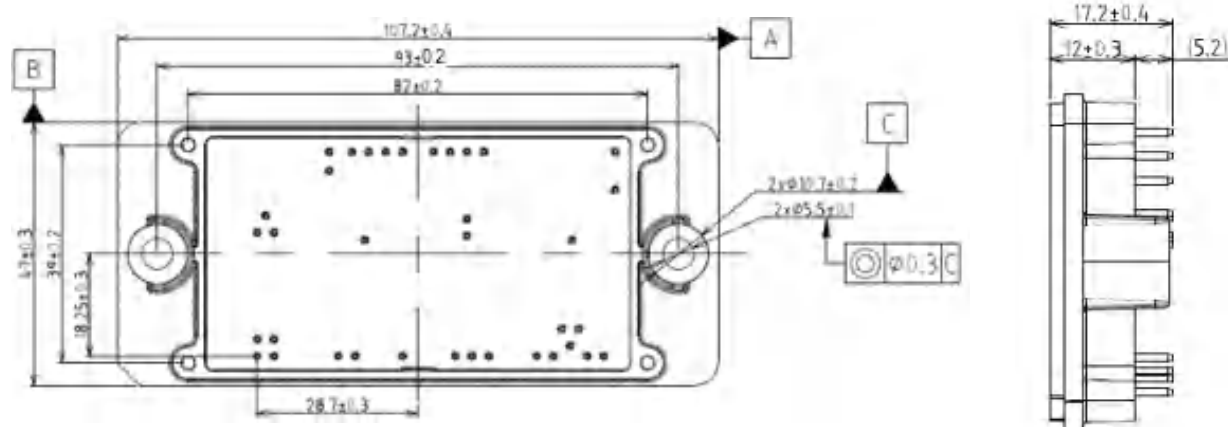
$I_c = f(V_{CE})$,
 $V_{GE} = +15\text{ V} / -7\text{ V}$, $R_{Goff} = 32\ \Omega$, $T_{vj} = 150^\circ\text{C}$



Circuit Diagram



Package Outlines



Package Outlines (continued)

